

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	
	LUU MATTHEW	3663	Page 1 of 1

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*	A	US-2002/0130870	09-2002	Ebihara, Hitoshi	345/440
*	B	US-2004/0223003	11-2004	Heirich et al.	345/629
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NON-PATENT DOCUMENTS

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